

## Preliminary Specification

## Linear Products

## DESCRIPTION

The TDA5703 is an 8-bit analog-to-digital converter (ADC) designed for video and professional applications. The TDA5703 converts the analog input signal into 8-bit binary-coded digital words at a sampling rate of up to 25MHz.

## FEATURES

- 8-bit binary coded resolution
- Digitizing rates up to 25MHz
- Internal reference
- Only 3 external capacitors required

## ORDERING INFORMATION

DESCRIPTION	TEMPERATURE RANGE	ORDER CODE
24-Pin Plastic DIP (SOT-101 BE17)	0 to +70°C	TDA5703N

## ABSOLUTE MAXIMUM RATINGS

SYMBOL	PARAMETER	RATING	UNIT
$V_{CC1}$	Supply voltages at Pin 4	8	V
$V_{CC2}$	at Pin 6	8	V
$V_{IN}$	Input voltage at Pins 1 and 5	8	V
$I_{OUT}$	Output current at Pins 9, 10, 11, 13, 14, 15, 16 and 17	10	mA
$T_{STG}$	Storage temperature range	-65 to +150	°C
$T_J$	Junction temperature	+125	°C
$T_A$	Operating ambient temperature range	0 to +70	°C

## Two voltage supply connections:

- analog +5V
- digital +5V

1V full-scale analog input ( $75\Omega$  external resistor tied to  $V_{CC1}$ )

## Full-scale bandwidth; 11MHz at 3dB

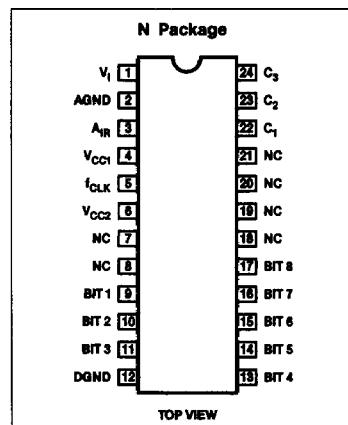
## Low power consumption; typically 250mW

## 24-lead plastic DIP

## APPLICATION

- Video data conversion

## PIN CONFIGURATION

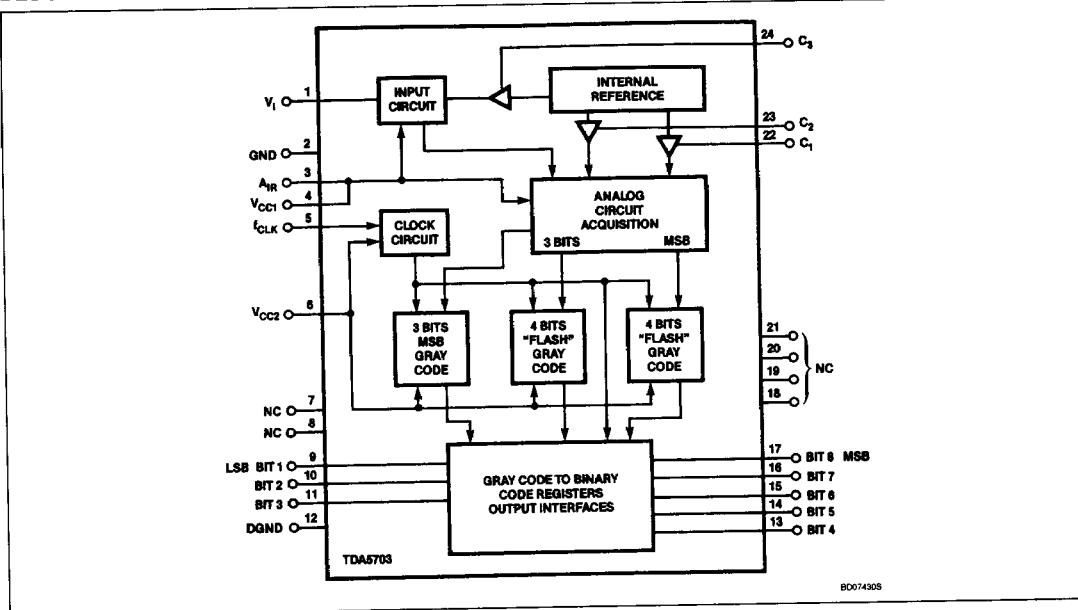


PIN NO.	SYMBOL	DESCRIPTION
1	$V_1$	Analog voltage input
2	AGND	Analog ground
3	$A_{IN}$	Analog input reference
4	$V_{CC1}$	Analog supply voltage
5	$f_{CLK}$	Clock input
6	$V_{CC2}$	Digital supply voltage
7	NC	Not connected
8	NC	Not connected
9	Bit 1	Least significant bit (LSB)
10	Bit 2	
11	Bit 3	
12	DGND	Digital ground
13	Bit 4	
14	Bit 5	
15	Bit 6	
16	Bit 7	
17	Bit 8	Most significant bit (MSB)
18	NC	Not connected
19	NC	Not connected
20	NC	Not connected
21	NC	Not connected
22	$C_1$	
23	$C_2$	
24	$C_3$	Decoupling for internal reference

## Analog-to-Digital Converter

TDA5703

## BLOCK DIAGRAM



## Analog-to-Digital Converter

TDA5703

**DC ELECTRICAL CHARACTERISTICS**  $V_{CC1} = V_{CC2} = 4.75$  to  $5.25V$ ;  $T_A = 25^\circ C$ , unless otherwise specified.

SYMBOL	PARAMETER	TEST CONDITIONS	LIMITS			UNIT
			Min	Typ	Max	
<b>Supply</b>						
$V_{CC1}$	Analog supply voltage	Pin 4	4.75	5.0	5.25	V
$V_{CC2}$	Digital supply voltage	Pin 6	4.75	5.0	5.25	V
$I_{CC1}$	Analog supply current	Pin 4	55	80	105	mA
$I_{CC2}$	Digital supply current	Pin 6	55	80	105	mA
Res	Resolution			8		bits
<b>Digital input levels<sup>1</sup></b>						
$V_{IH}$	Input voltage HIGH		2.2			V
$V_{IL}$	Input voltage LOW		-0.3		0.8	V
$I_{IH}$	Input current HIGH				10	$\mu A$
$I_{IL}$	Input current LOW		-7	350		$\mu A$
Analog input levels			$V_{CC1}^{-1}$		$V_{CC1}$	V
Absolute linearity		$V_1$	-1.5	<del>-5.85</del>	+1.5	LSB
Differential linearity		$V_1$	-1.5		+1	LSB
BW	Bandwidth	1dB 3dB	6.0	6.0	10	MHz MHz
Differential phase Differential gain		$F_0 = 25\text{MHz}$ , measured with TDA5702		1		deg. %
	Offset error			2.3		
$R_{IN}$	Input resistance			40		mV
$C_{IN}$	Input capacitance			80		$k\Omega$
<b>Digital output levels</b> ( $I_O = 10\text{mA}$ )						
$V_{OH}$	Output voltage HIGH		2.4			V
$V_{OL}$	Output voltage LOW				0.40	V
$C_O$	External capacitance	$C_1, C_2, C_3$		100		nF
<b>Temperature</b>						
$T_A$	Operating ambient temperature range		0		+70	$^\circ C$

**AC ELECTRICAL CHARACTERISTICS**  $V_{CC1} = V_{CC2} = 4.75$  to  $5.25V$ ;  $T_A = 25^\circ C$ , unless otherwise specified.

SYMBOL	PARAMETER	TEST CONDITIONS	LIMITS			UNIT
			Min	Typ	Max	
<b>Timing</b>						
$f_C$	Maximum conversion rate		25	<del>40</del>	per $\text{MHz}$	MHz
$t_{DELAY}$	Aperture delay <sup>1</sup>			19		ns
$t_D$	Digital output delay <sup>1</sup>			28		ns
$t_{PWH}$	Pulse width conversion HIGH <sup>1</sup>		20			ns
$t_{PWL}$	Pulse width conversion LOW <sup>1</sup>		20			ns

## NOTE:

- See Timing Diagram, Figure 1